Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,434	JENSEN ET AL.
Examiner	Art Unit
David Mis	2817

SEARCHED			
Class	Subclass	Date	Examiner
331	1A, 14, 16- 18, 23, 25, Dig. 2	2/10/2005	DM
327	156-159		
332	127		
360	51		
375	376		
455	260		
MOAL	TEO	7/145	9

	INTERFERENCE SEARCHED			
Cla	ss	Subclass	Date	Examiner
AS	A	PONE	7/25	D.
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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